

## MOSFET

### OptiMOS™ 7 Power-Transistor, 80 V

#### Features

- N-channel, normal level
- Optimized for synchronous rectification and motor drives
- Soft recovery body diode
- 100% avalanche tested
- 175°C rated
- Pb-free lead plating; RoHS compliant
- Halogen-free according to IEC61249-2-21

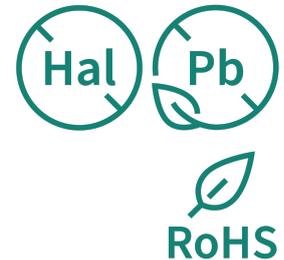
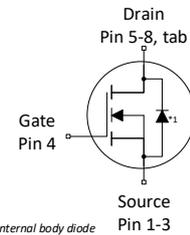
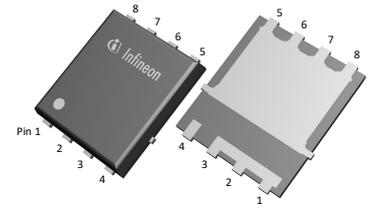
#### Product validation

Qualified for industrial applications according to the relevant tests of JEDEC JESD47, JESD22 and J-STD-020.

**Table 1** Key performance parameters

Parameter	Value	Unit
$V_{DS}$	80	V
$R_{DS(on),max}$	2.4	mΩ
$I_D$	167	A
$Q_{OSS}$	95	nC
$Q_G(0V..10V)$	49	nC
$Q_{rr}(100A/\mu s)$	22	nC

PG-TDSON-8



Part number	Package	Marking	Related links
ISC024N08NM7	PG-TDSON-8	024N08N7	-



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## 1 Maximum ratings

at  $T_A=25\text{ °C}$ , unless otherwise specified

**Table 2 Maximum ratings**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Continuous drain current <sup>1)</sup>	$I_D$	-	-	167	A	$V_{GS}=10\text{ V}, T_C=25\text{ °C}$
				118		$V_{GS}=10\text{ V}, T_C=100\text{ °C}$
				107		$V_{GS}=7\text{ V}, T_C=100\text{ °C}$
				24		$V_{GS}=10\text{ V}, T_A=25\text{ °C}, R_{THJA}=50\text{ °C/W}^2)$
Pulsed drain current <sup>3)</sup>	$I_{D,pulse}$	-	-	668	A	$T_C=25\text{ °C}$
Avalanche energy, single pulse <sup>4)</sup>	$E_{AS}$	-	-	110	mJ	$I_D=50\text{ A}, R_{GS}=25\text{ }\Omega$
Gate source voltage	$V_{GS}$	-20	-	20	V	-
Power dissipation	$P_{tot}$	-	-	150	W	$T_C=25\text{ °C}$
				3.0		$T_A=25\text{ °C}, R_{THJA}=50\text{ °C/W}^2)$
Operating and storage temperature	$T_j, T_{stg}$	-55	-	175	°C	-

<sup>1)</sup> Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature as specified. For other case temperatures please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.

<sup>2)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

<sup>3)</sup> See Diagram 3 for more detailed information

<sup>4)</sup> See Diagram 13 for more detailed information

## 2 Thermal characteristics

**Table 3 Thermal characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Thermal resistance, junction - case, bottom	$R_{thJC}$			1	°C/W	-
Thermal resistance, junction - case, top	$R_{thJC}$	-	-	20		
Thermal resistance, junction - ambient, 6 cm <sup>2</sup> cooling area <sup>5)</sup>	$R_{thJA}$			50		

<sup>5)</sup> Device on 40 mm x 40 mm x 1.5 mm epoxy PCB FR4 with 6 cm<sup>2</sup> (one layer, 70 µm thick) copper area for drain connection. PCB is vertical in still air.

### 3 Electrical characteristics

at  $T_j=25\text{ °C}$ , unless otherwise specified

**Table 4 Static characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Drain-source breakdown voltage	$V_{(BR)DSS}$	80	-	-	V	$V_{GS}=0\text{ V}$ , $I_D=1\text{ mA}$
Gate threshold voltage	$V_{GS(th)}$	2.3	2.8	3.2	V	$V_{DS}=V_{GS}$ , $I_D=71\text{ }\mu\text{A}$
Zero gate voltage drain current	$I_{DSS}$	-	-	1	$\mu\text{A}$	$V_{DS}=80\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=25\text{ °C}$
Zero gate voltage drain current <sup>6)</sup>	$I_{DSS}$	-	-	100	$\mu\text{A}$	$V_{DS}=80\text{ V}$ , $V_{GS}=0\text{ V}$ , $T_j=125\text{ °C}$
Gate-source leakage current	$I_{GSS}$	-	-	100	nA	$V_{GS}=20\text{ V}$ , $V_{DS}=0\text{ V}$
Drain-source on-state resistance	$R_{DS(on)}$	-	2.1	2.4	m $\Omega$	$V_{GS}=10\text{ V}$ , $I_D=50\text{ A}$
			2.4	2.9		$V_{GS}=7\text{ V}$ , $I_D=25\text{ A}$
Gate resistance	$R_G$	-	1.2	-	$\Omega$	-
Transconductance <sup>6)</sup>	$g_{fs}$	65	130	-	S	$ V_{DS} \geq 2 I_D $ , $R_{DS(on)max}$ , $I_D=50\text{ A}$

<sup>6)</sup> Defined by design. Not subject to production test.

**Table 5 Dynamic characteristics**

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Input capacitance <sup>7)</sup>	$C_{iss}$	-	3500	4600	pF	$V_{GS}=0\text{ V}$ , $V_{DS}=40\text{ V}$ , $f=1\text{ MHz}$
Output capacitance <sup>7)</sup>	$C_{oss}$		1440	1870		
Reverse transfer capacitance <sup>7)</sup>	$C_{rss}$		21	37		
Turn-on delay time	$t_{d(on)}$	-	10.3	-	ns	$V_{DD}=40\text{ V}$ , $V_{GS}=10\text{ V}$ , $I_D=50\text{ A}$ , $R_{G,ext}=1.6\text{ }\Omega$
Rise time	$t_r$		3.8			
Turn-off delay time	$t_{d(off)}$		20.4			
Fall time	$t_f$		5.0			

<sup>7)</sup> Defined by design. Not subject to production test.

**Table 6 Gate charge characteristics** <sup>8)</sup>

Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Gate to source charge <sup>9)</sup>	$Q_{gs}$	-	16	21	nC	$V_{DD}=40\text{ V}$ , $I_D=50\text{ A}$ , $V_{GS}=0\text{ to }10\text{ V}$
Gate charge at threshold	$Q_{g(th)}$	-	9.9	-	nC	
Gate to drain charge <sup>9)</sup>	$Q_{gd}$	-	8.9	13	nC	
Switching charge	$Q_{sw}$	-	15	-	nC	
Gate charge total <sup>9)</sup>	$Q_g$	-	49	64	nC	
Gate plateau voltage	$V_{plateau}$	-	4.6	-	V	
Gate charge total, sync. FET	$Q_{g(sync)}$	-	44	-	nC	$V_{DS}=0.1\text{ V}$ , $V_{GS}=0\text{ to }10\text{ V}$
Output charge <sup>9)</sup>	$Q_{oss}$	-	95	124	nC	$V_{DS}=40\text{ V}$ , $V_{GS}=0\text{ V}$

<sup>8)</sup> See "Gate charge waveforms" for parameter definition

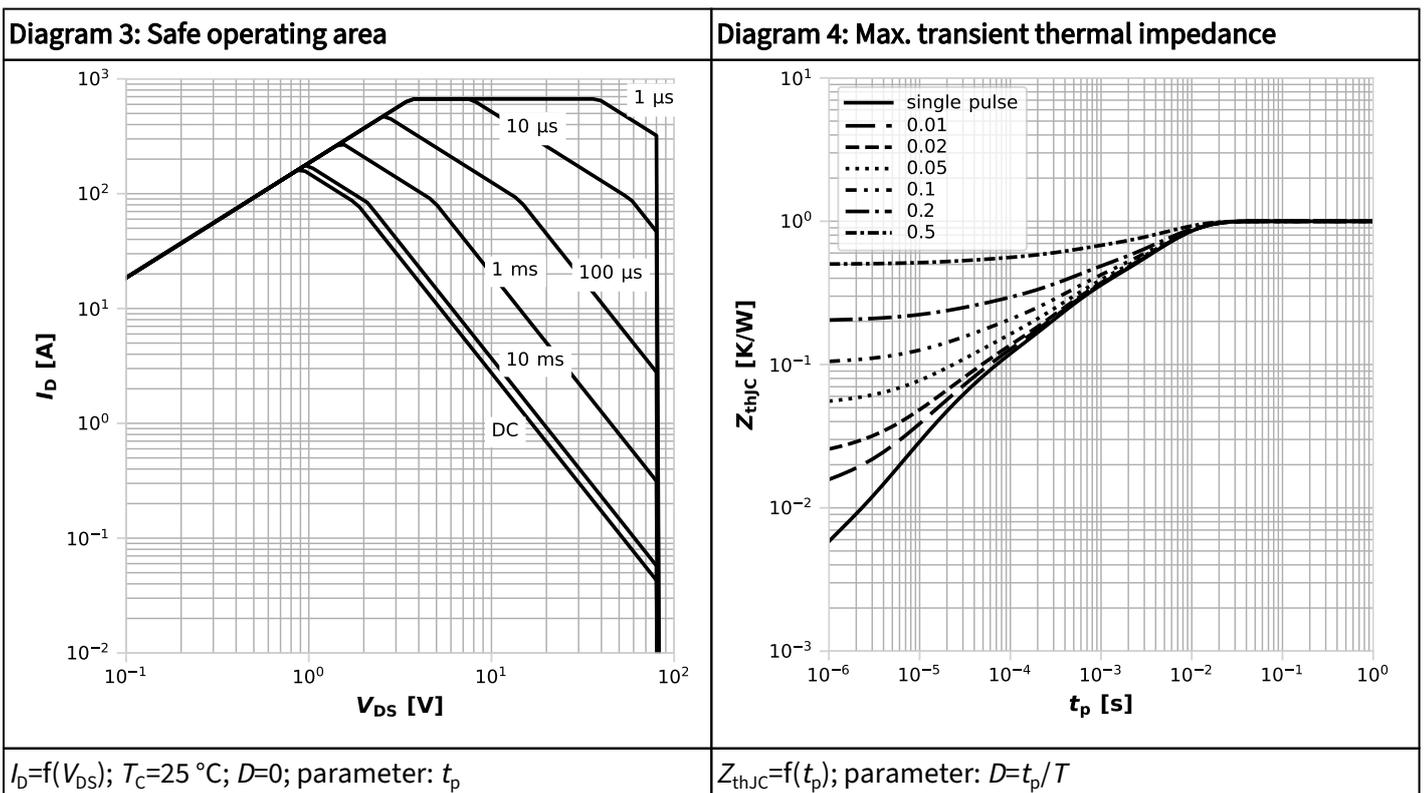
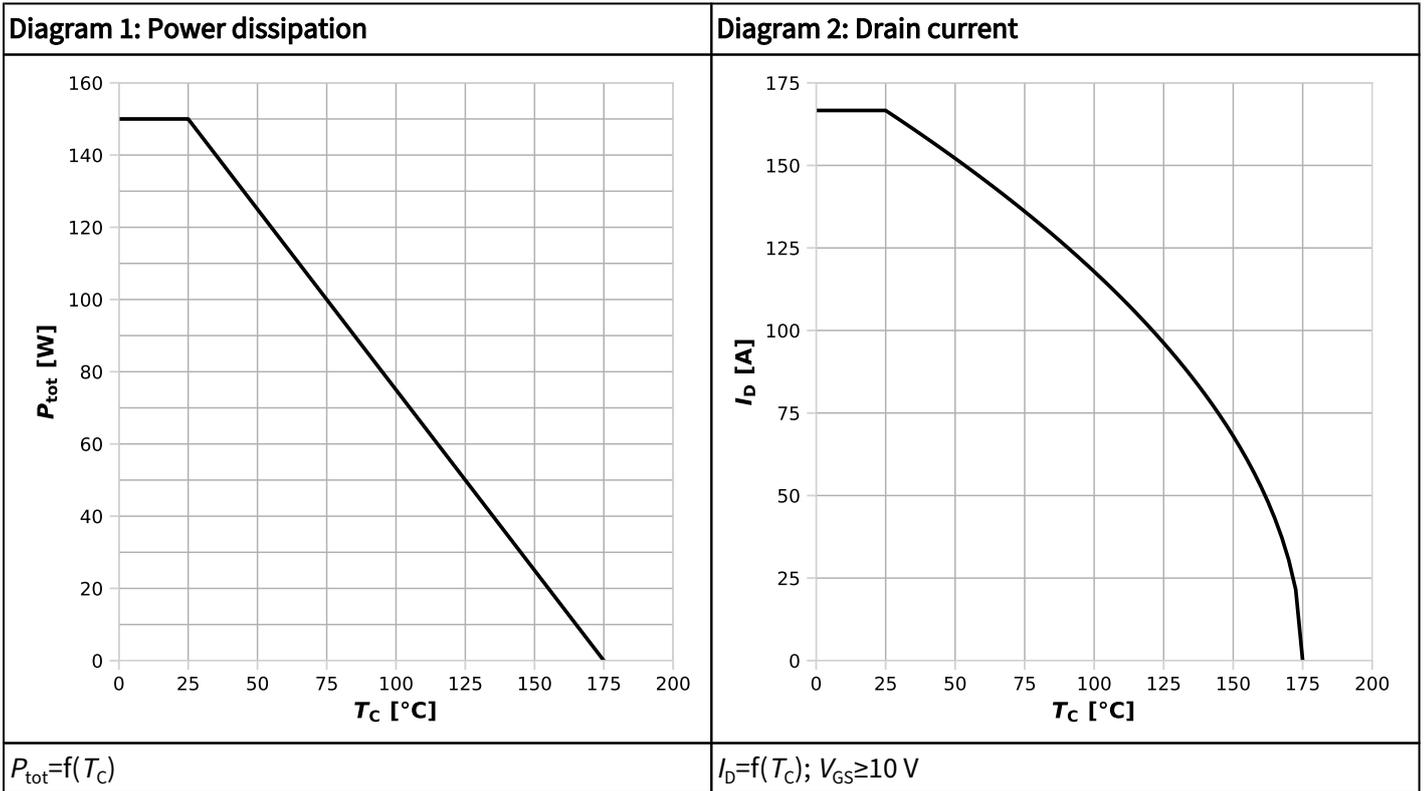
<sup>9)</sup> Defined by design. Not subject to production test.

**Table 7 Reverse diode**

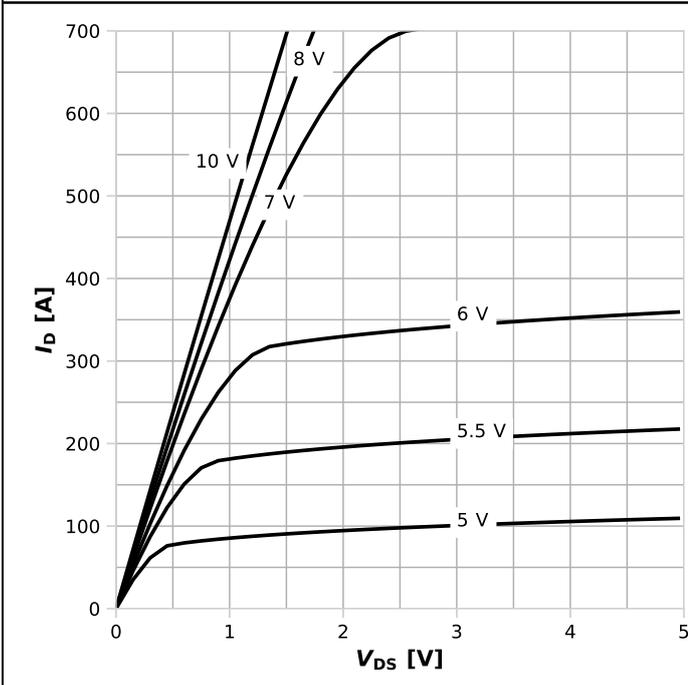
Parameter	Symbol	Values			Unit	Note / Test condition
		Min.	Typ.	Max.		
Diode continuous forward current	$I_S$	-	-	142	A	$T_C=25\text{ °C}$
Diode pulse current	$I_{S,pulse}$	-	-	668		
Diode forward voltage	$V_{SD}$	-	0.87	1.0	V	$V_{GS}=0\text{ V}$ , $I_F=50\text{ A}$ , $T_j=25\text{ °C}$
Reverse recovery time <sup>10)</sup>	$t_{rr}$	-	34	51	ns	$V_R=40\text{ V}$ , $I_F=50\text{ A}$ , $di_F/dt=100\text{ A}/\mu\text{s}$
Reverse recovery charge <sup>10)</sup>	$Q_{rr}$	-	22	44	nC	

<sup>10)</sup> Defined by design. Not subject to production test.

## 4 Electrical characteristics diagrams

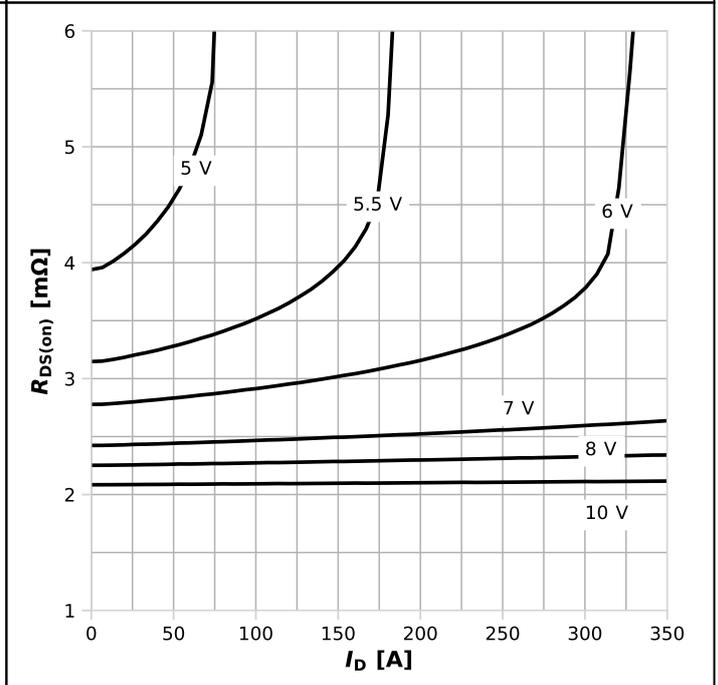


**Diagram 5: Typ. output characteristics**



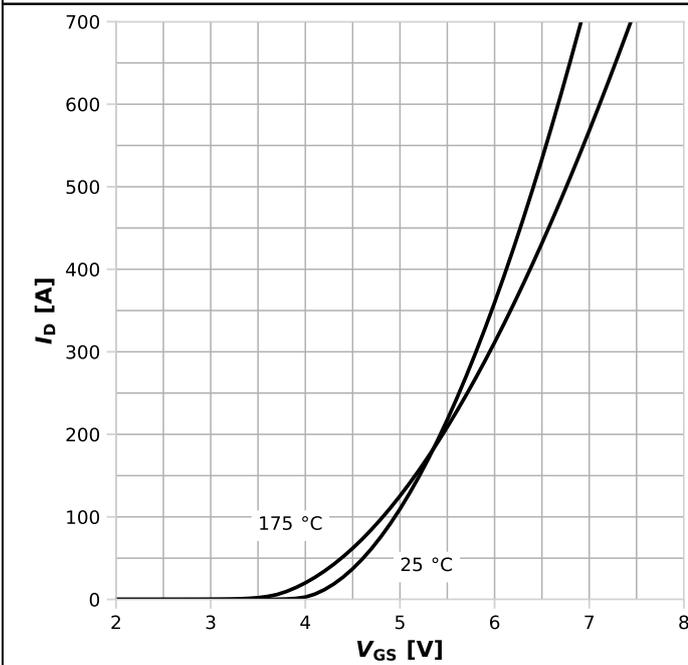
$I_D = f(V_{DS})$ ,  $T_j = 25\text{ °C}$ ; parameter:  $V_{GS}$

**Diagram 6: Typ. drain-source on resistance**



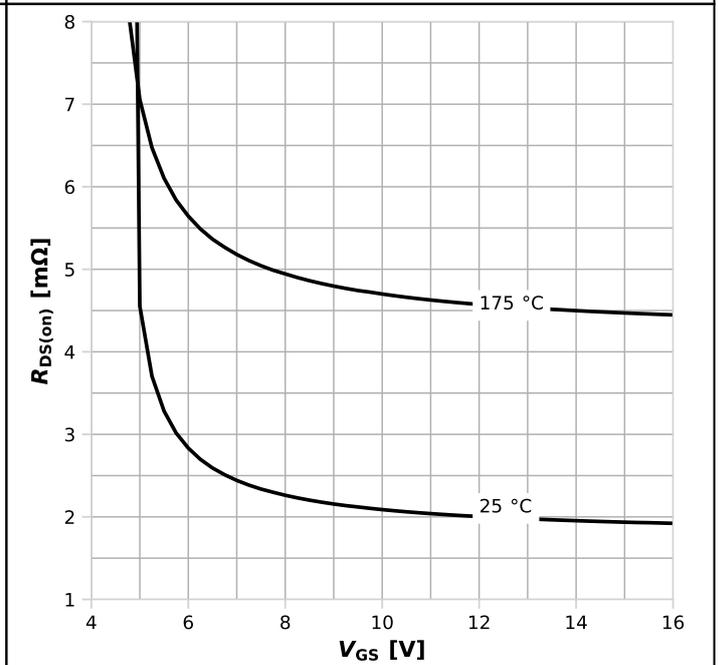
$R_{DS(on)} = f(I_D)$ ,  $T_j = 25\text{ °C}$ ; parameter:  $V_{GS}$

**Diagram 7: Typ. transfer characteristics**



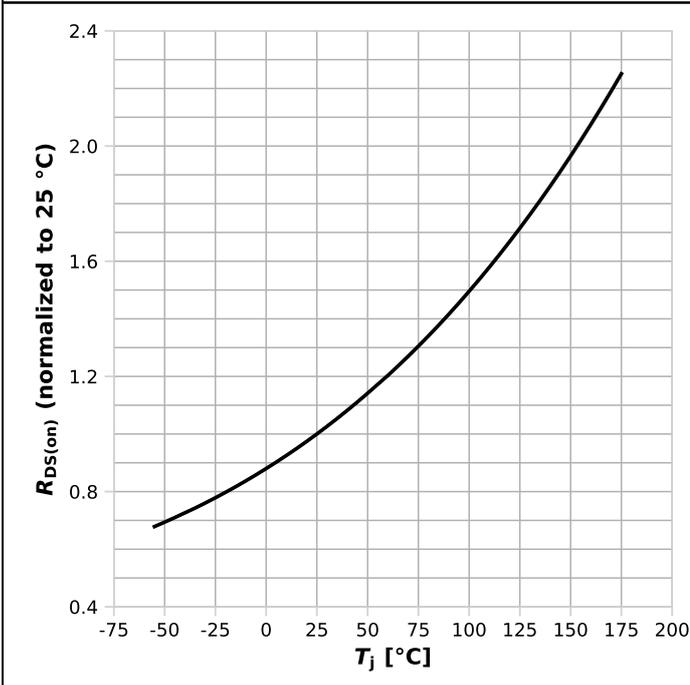
$I_D = f(V_{GS})$ ,  $|V_{DS}| > 2|I_D|R_{DS(on)max}$ ; parameter:  $T_j$

**Diagram 8: Typ. drain-source on resistance**



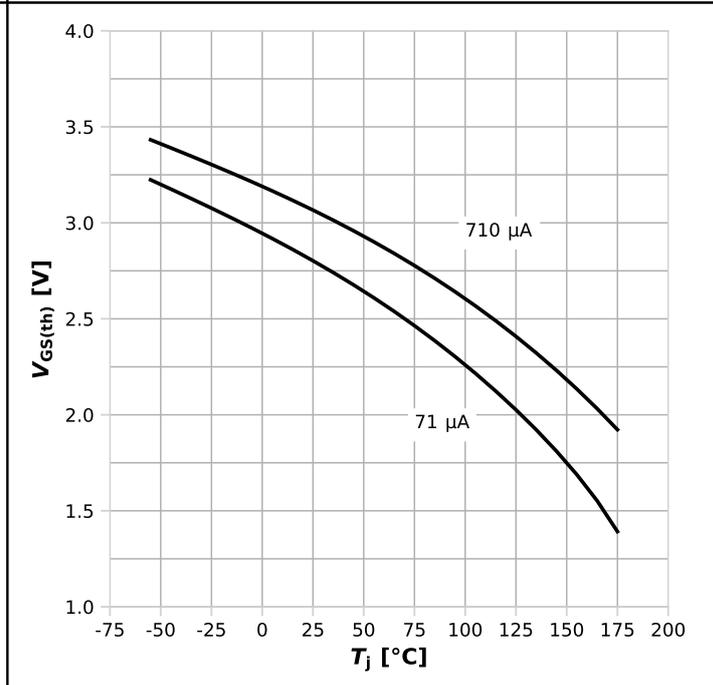
$R_{DS(on)} = f(V_{GS})$ ,  $I_D = 50\text{ A}$ ; parameter:  $T_j$

**Diagram 9: Normalized drain-source on resistance**



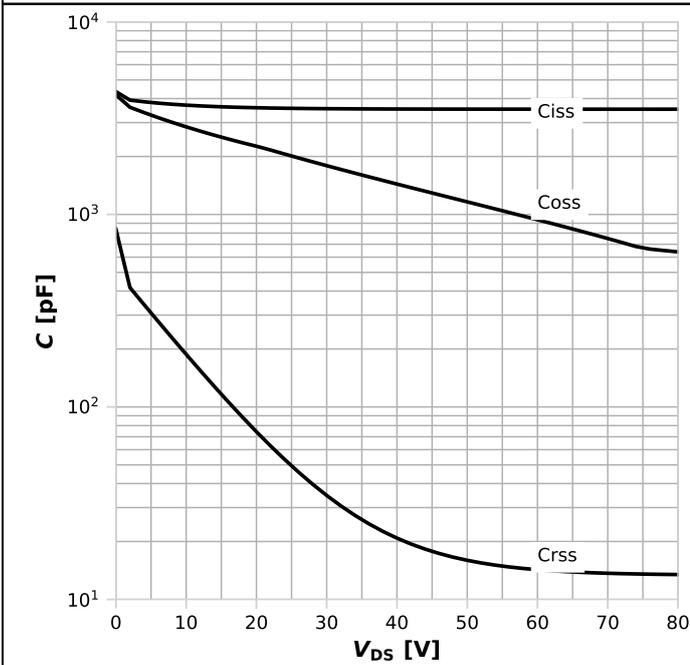
$R_{DS(on)}=f(T_j)$ ,  $I_D=50$  A,  $V_{GS}=10$  V

**Diagram 10: Typ. gate threshold voltage**



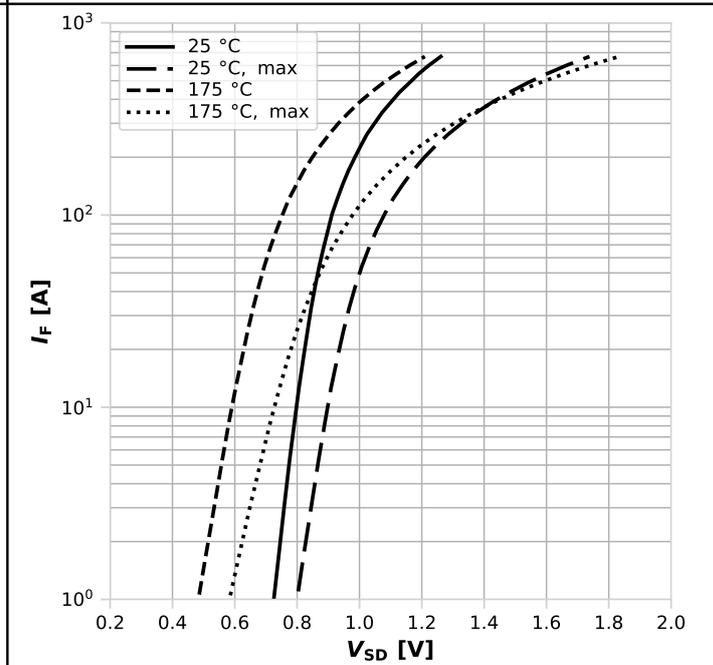
$V_{GS(th)}=f(T_j)$ ,  $V_{GS}=V_{DS}$ ; parameter:  $I_D$

**Diagram 11: Typ. capacitances**



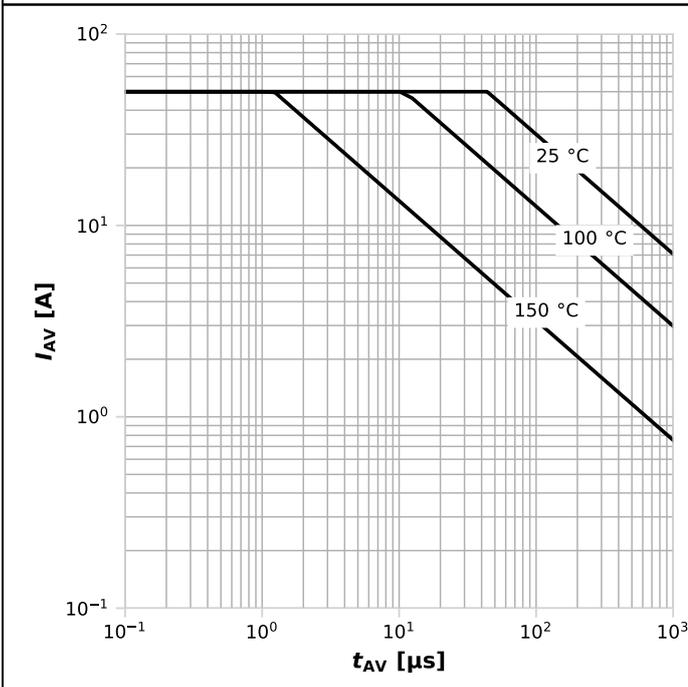
$C=f(V_{DS})$ ;  $V_{GS}=0$  V;  $f=1$  MHz

**Diagram 12: Forward characteristics of reverse diode**



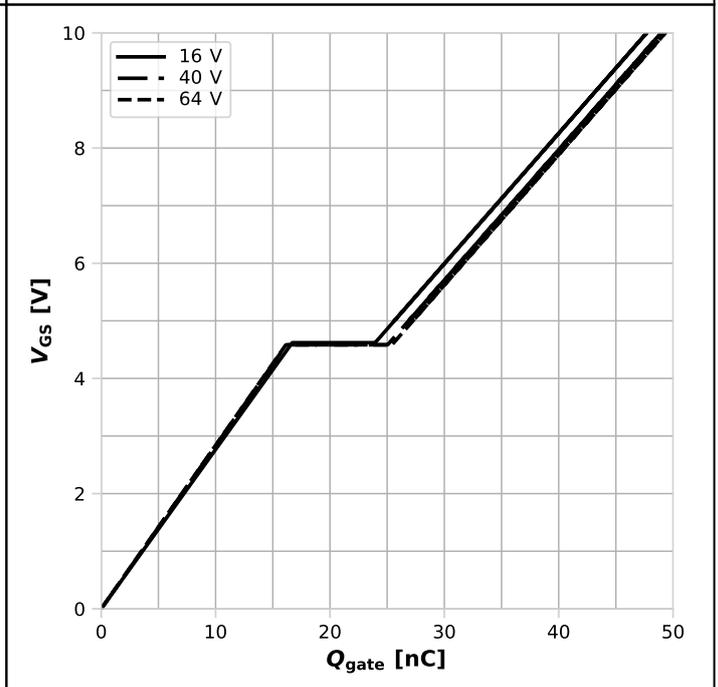
$I_F=f(V_{SD})$ ; parameter:  $T_j$

**Diagram 13: Avalanche characteristics**



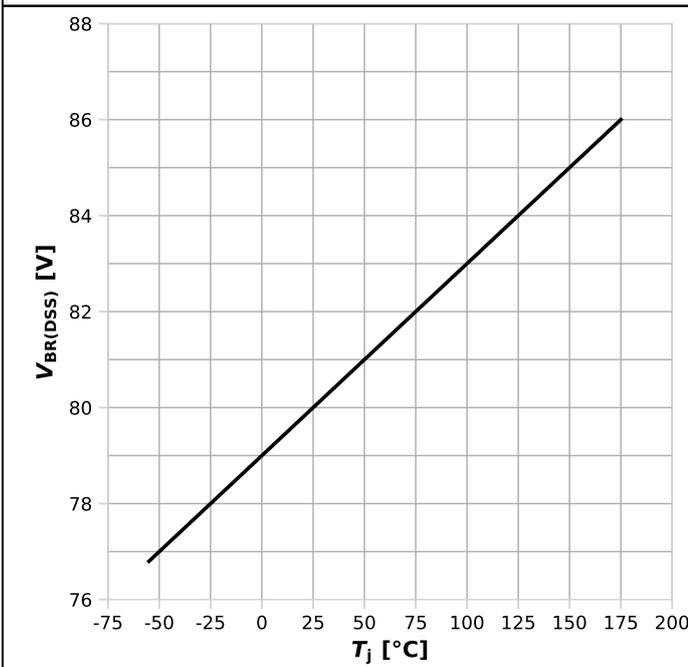
$I_{AS}=f(t_{AV}); R_{GS}=25 \Omega$ ; parameter:  $T_{j,start}$

**Diagram 14: Typ. gate charge**



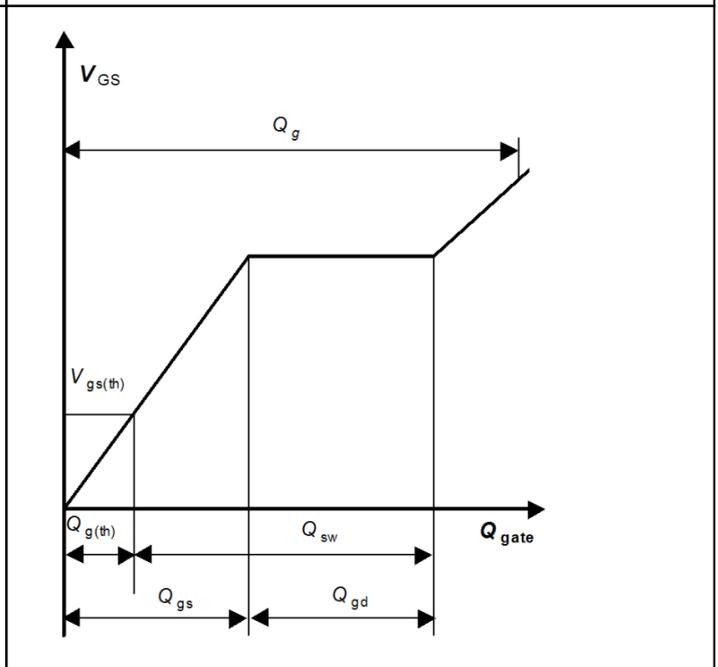
$V_{GS}=f(Q_{gate}), I_D=50 \text{ A pulsed}, T_j=25 \text{ °C}$ ; parameter:  $V_{DD}$

**Diagram 15: Drain-source breakdown voltage**



$V_{BR(DSS)}=f(T_j); I_D=1 \text{ mA}$

**Gate charge waveforms**



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## 5 Package outlines

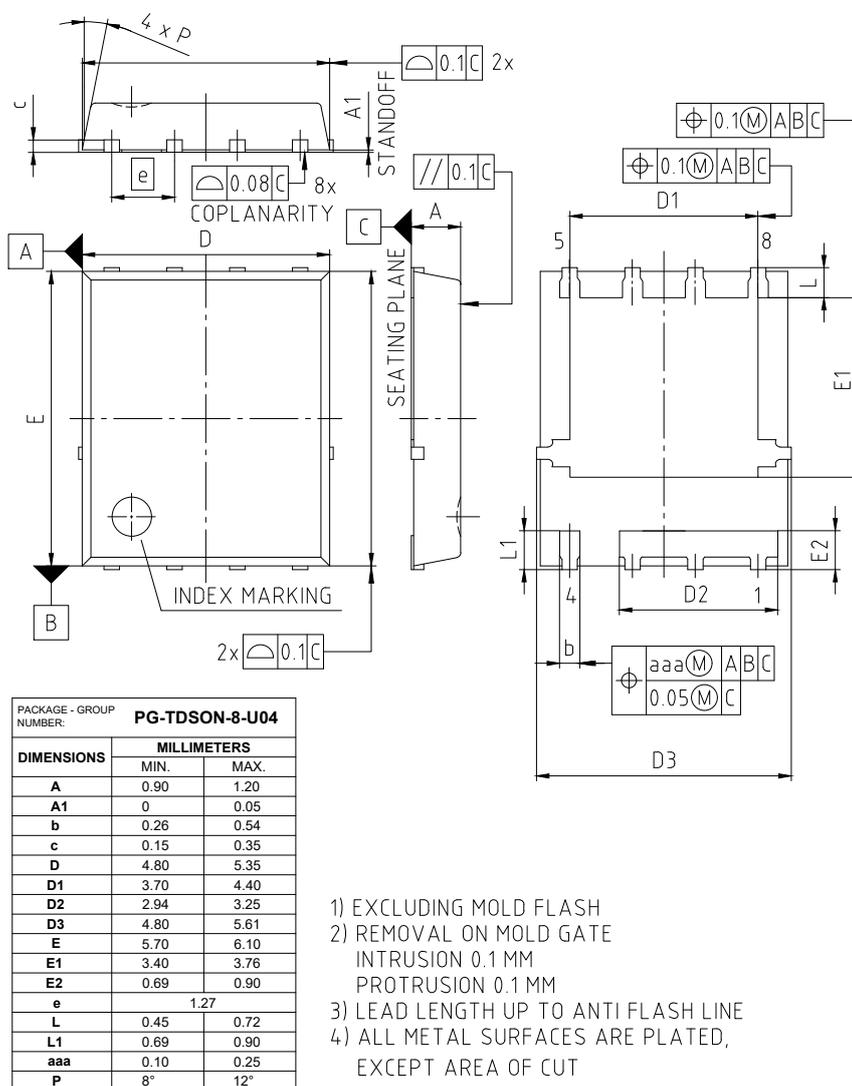
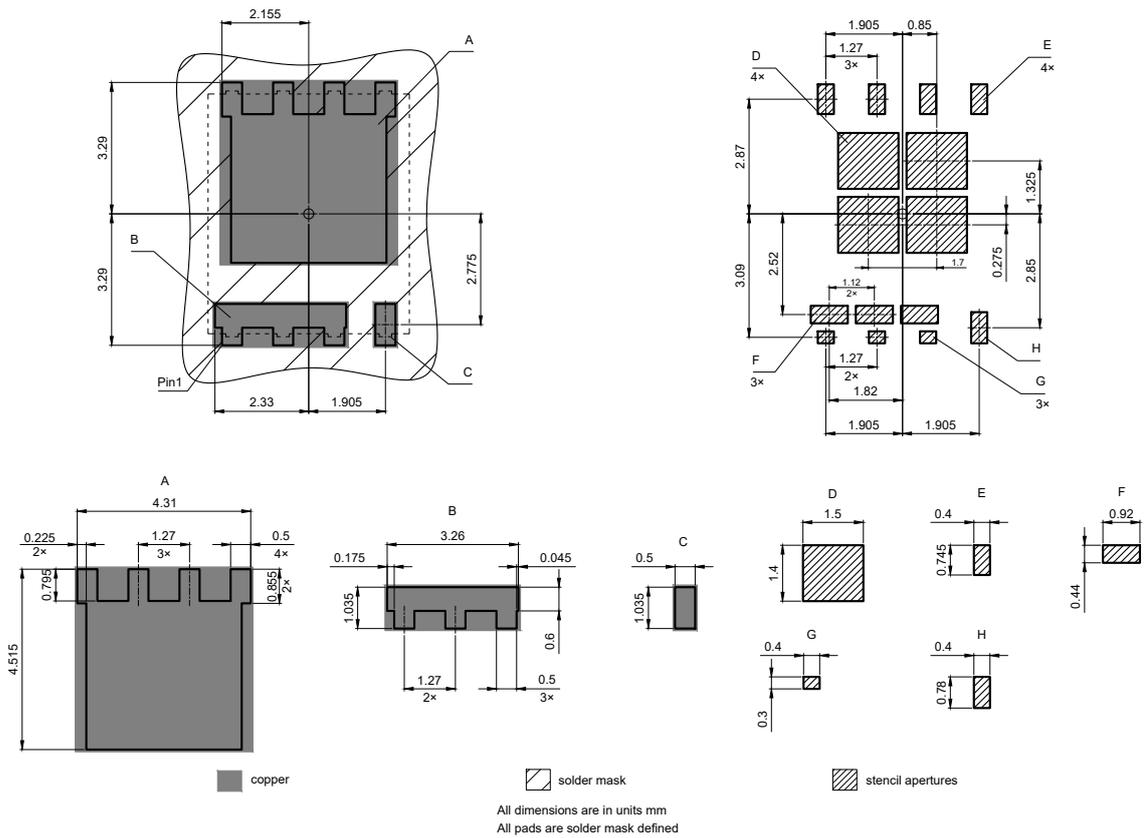


Figure 1 Outline PG-TDSON-8, dimensions in mm



**Figure 2 Footprint drawing PG-TDSON-8, dimensions in mm**

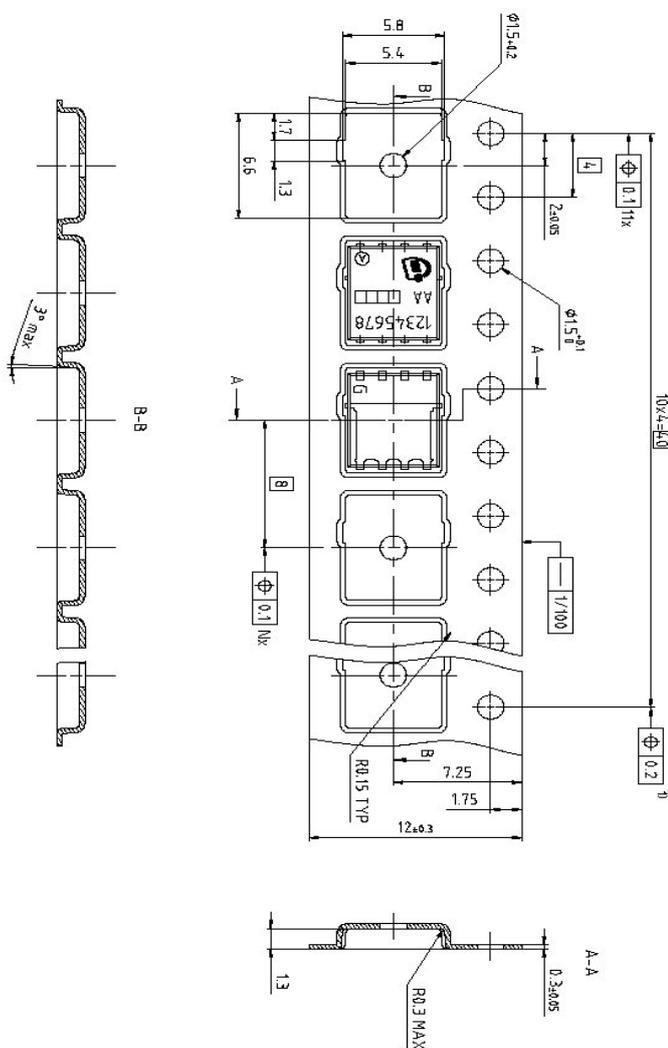


Figure 3 Packaging variant PG-TDSON-8, dimensions in mm



**Revision history**

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ISC024N08NM7

**Revision 2025-10-31, Rev. 1.0**

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Previous revisions

Revision	Date	Subjects (major changes since last revision)
1.0	2025-10-31	Release of final version

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